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### 1 On lossless quantum data compression with a classical helper

Ahlsweide, R.; Ning Cai;

Information Theory, IEEE Transactions on , Volume: 50 , Issue: 6 , June 2004

Pages:1208 - 1219

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Kramer, G.; Savari, S.A.;

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Pages:44

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### 3 Low-threshold 1.5 $\mu\text{m}$ compressive-strained multiple- and single-quantum-well lasers

Zah, C.-E.; Bhat, R.; Favire, F.J., Jr.; Menocal, S.G.; Andreadakis, N.C.; Cheung, K.-W.; Hwang, D.-M.D.; Koza, M.A.; Lee, T.-P.;

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Pages:1440 - 1450

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### 4 Compressing quantum mixed-state sources by sending classical information

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$\mu\text{m}$

*Guodong Zhang;*

Selected Topics in Quantum Electronics, IEEE Journal of , Volume: 1 , Issue: 2 , June 1995

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**6 Optimization of long wavelength InGaAsP strained quantum-well lasers**

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*Nielsen, N.C.; Kuhl, J.; Khitrova, G.; Gibbs, H.M.; Giessen, H.;*

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**11 Reversible arithmetic coding for quantum data compression**

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**13 Threshold current analysis of compressive strain (0-1.8%) in low-threshold, long-wavelength quantum well lasers**

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